T0805xH T0809xH

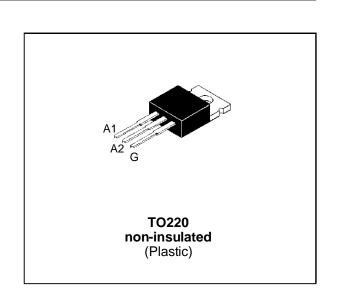
SENSITIVE GATE TRIACS

FEATURES

- $I_{T(RMS)} = 8A$
- $V_{DRM} = 400 \text{V to } 800 \text{V}$
- $I_{GT} \le 5mA$ to $\le 10mA$



The T08xxxH series of triacs uses a high performance MESA GLASS technology. These parts are intended for general purpose applications where gate high sensitivity is required.



ABSOLUTE RATINGS (limiting values)

| Symbol | Parameter | Value | Unit | |
|------------------------------------|---|----------------------------|------|------------------|
| I _{T(RMS)} | RMS on-state current (360° conduction angle) | Tc= 95 °C | 8 | А |
| I _{TSM} | Non repetitive surge peak on-state current tp = | | 73 | Α |
| | (T _j initial = 25°C) | tp = 10 ms | 70 | |
| l ² t | I^2 t Value for fusing $tp = 10 \text{ ms}$ | | 24 | A ² s |
| dl/dt | Critical rate of rise of on-state current $I_G = 50 \text{ mA}$ $di_G/dt = 0.1 \text{ A/}\mu\text{s}$. | | 10 | A/μs |
| | | Non Repetitive | 50 | |
| T _{stg} T _j | Storage and operating junction temperature | - 40, + 150 - 40, + 125 | °C | |
| TI | Maximum lead temperature for soldering dur 4.5mm from case | 260 | °C | |

| Symbol | Parameter | | Unit | | | |
|--------------|--|-----|------|-----|-----|---|
| | | D | М | S | N | |
| VDRM VRRM | Repetitive peak off-state voltage $T_j = 125^{\circ}C$ | 400 | 600 | 700 | 800 | V |

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T0805xH/T0809xH

THERMAL RESISTANCES

| Symbol | Parameter | Value | Unit |
|----------|---|-------|------|
| Rth(j-a) | Junction to ambient | 60 | °C/W |
| Rth(j-c) | Junction to case for D.C | 4 | °C/W |
| Rth(j-c) | Junction to case for A.C 360° conduction angle (F=50Hz) | 3 | °C/W |

GATE CHARACTERISTICS (maximum values)

 $P_{G (AV)} = 1 W$ $P_{GM} = 10 W (tp = 20 \mu s)$ $I_{GM} = 4 A (tp = 20 \mu s)$

ELECTRICAL CHARACTERISTICS

| Symbol | Test Conditions | | Quadrant | | Sensitivity | | Unit |
|-------------------|--|-----------|-------------|-----|-------------|----|------|
| Syllibol | rest conditions | • | Quadrant | | 05 | 09 | |
| IGT | $V_D=12V$ (DC) $R_L=33\Omega$ | Tj= 25°C | I-II-III-IV | MAX | 5 | 10 | mA |
| V _{GT} | $V_D=12V$ (DC) $R_L=33\Omega$ | Tj= 25°C | I-II-III-IV | MAX | 1 | .5 | V |
| V_{GD} | $V_D=V_{DRM}$ $R_L=3.3k\Omega$ | Tj= 125°C | I-II-III-IV | MIN | 0.2 | | V |
| tgt | $\begin{array}{ll} V_D {=} V_{DRM} & I_G = 40 mA \\ I_T = 11 A \\ dI_G {/} dt = 0.5 A {/} \mu s \end{array}$ | Tj= 25°C | I-II-III-IV | TYP | 2 | | μs |
| I _H * | I _T = 50mA Gate open | Tj= 25°C | | MAX | 5 | 10 | mA |
| IL | I _G = 1.2 I _{GT} | Tj= 25°C | I-III-IV | TYP | 5 | 10 | mA |
| | | | II | TYP | 10 | 20 | |
| V _{TM} * | ITM=11A tp=380μs | Tj= 25°C | | MAX | 1.65 | | V |
| IDRM | $V_D = V_{DRM}$ $V_R = V_{RRM}$ | Tj= 25°C | | MAX | 5 | | μΑ |
| I _{RRM} | | Tj= 110°C | | MAX | 2 | | mA |
| dV/dt * | VD=67%V _{DRM} | Tj= 110°C | | MIN | | 20 | V/μs |
| | Gate open | | | TYP | 10 | |] |
| (dV/dt)c* | (dl/dt)c = 3.5 A/ms | Tj= 110°C | | TYP | 1 2 | | V/μs |

^{*} For either polarity of electrode A₂ voltage with reference to electrode A₁

ORDERING INFORMATION

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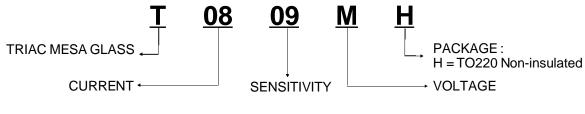
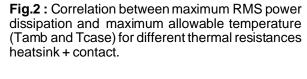
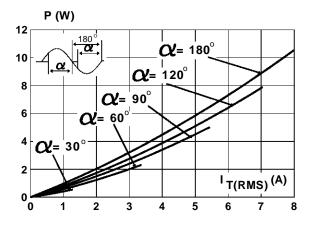


Fig.1: Maximum RMS power dissipation versus RMS on-state current.

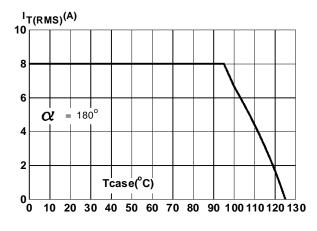




P (W) Tcase (°C) 12 = 0°C/W 2.5°C/W 5°C/W 7.5°C/W 95 10 100 8 -105 6 -110 -115 2 120 Tamb (°C) 125 20 140 40 100 120 0 60 80

Fig.3: RMS on-state current versus case temperature.

Fig.4: Relative variation of thermal impedance versus pulse duration.



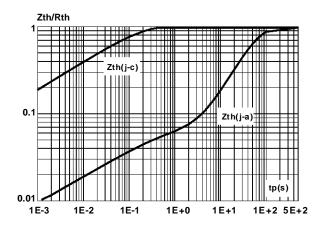
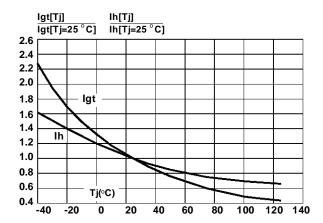


Fig.5: Relative variation of gate trigger current and holding current versus junction temperature.

Fig.6: Non repetitive surge peak on-state current versus number of cycles.



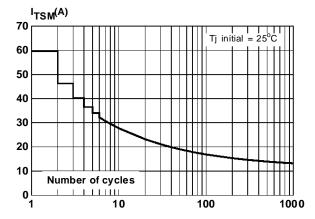
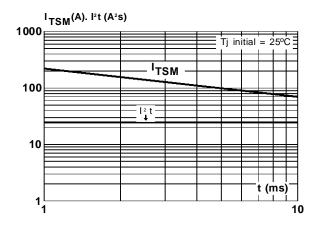
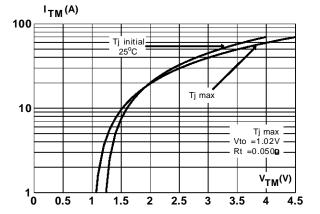


Fig.7: Non repetitive surge peak on-state current for a sinusoidal pulse with width : $t \le 10$ ms, and corresponding value of l^2t .

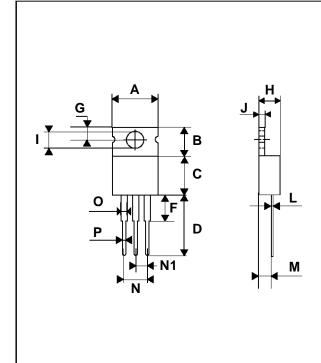
 $\textbf{Fig.8:} \ \textbf{On-state characteristics (maximum values)}.$





PACKAGE MECHANICAL DATA

TO220 Non-insulated (Plastic)



| | DIMENSIONS | | | | | | |
|------|-------------|------|------|--------|-------|-------|--|
| REF. | Millimeters | | | Inches | | | |
| | Тур. | Min. | Max. | Тур. | Min. | Max. | |
| Α | | | 10.3 | | | 0.406 | |
| В | | 6.3 | 6.5 | 0.248 | 0.256 | | |
| С | | | 9.1 | | | 0.358 | |
| D | | 12.7 | | | 0.500 | | |
| F | | | 4.2 | | | 0.165 | |
| G | | | 3.0 | | | 0.118 | |
| Н | | 4.5 | 4.7 | | 0.177 | 0.185 | |
| Ī | | 3.53 | 3.66 | | 0.139 | 0.144 | |
| J | | 1.2 | 1.3 | | 0.047 | 0.051 | |
| L | | | 0.9 | | | 0.035 | |
| М | 2.7 | | | 0.106 | | | |
| N | | | 5.3 | | | 0.209 | |
| N1 | 2.54 | | | 0.100 | | | |
| 0 | | 1.2 | 1.4 | | 0.047 | 0.055 | |
| Р | | | 1.15 | | | 0.045 | |

Marking: type number

Weight: 1.8 g

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